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	10727039	CHEN ET AL.
Examiner	Art Unit	
Lee, John W	2624	

Lee, John W (Assistant Examiner)	2/13/2008 (Date)	JINGE WU SUPERVISORY PATENT EXAMINER	Total Claims Allowed:  25
(Legal Instruments Examiner)	(Date)	(Primary Examiner)	O.G. Print Claim(s)  1
		(Date) 2/13/08	O.G. Print Figure  FIG. 1A